

Notice of References Cited	Application/Control No. 10/576,165		Applicant(s)/Patent Under Reexamination THELEN ET AL.	
	Examiner Pinkal R. Chokshi		Art Unit 2425	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0120373	06-2005	Thomas et al.	725/058
*	B	US-2002/0021766	02-2002	Iwai, Keisuke	375/316
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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